

<b>Notice of References Cited</b>	Application/Control No. 10/600,332	Applicant(s)/Patent Under Reexamination PARK ET AL.	
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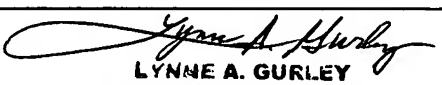
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	C	US-6,255,176	07-2001	Kim et al.	438/296
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	W	 <b>LYNNE A. GURLEY</b> <b>PRIMARY PATENT EXAMINER</b> <b>TC 2800, AU 2812</b>
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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